

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0082575	04-2005	Chen et al.	257/202
	B	US-			
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	E	US-			
	F	US-			
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	K	US-			
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#### NON-PATENT DOCUMENTS

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